

Application No.: 10/797,890

Case No.: 59474US002

AMENDMENT TO THE CLAIMS:

The following list of claims will replace all prior versions of claims in the application:

1. (currently amended) A wafer planarization system comprising:
an electrical source having a first electrode and a second electrode;
a polishing pad carrier connected to said first electrode;
a workpiece carrier connected to said second electrode;
a conditioning tool comprising an abrasive surface adapted to condition said polishing pad; and
an electrical insulator configured to isolate said abrasive surface from at least one of said first electrode and said second electrode;
wherein said conditioning tool comprises said electrical insulator; wherein said conditioning tool further comprises an electrically insulated conditioning disk comprising said abrasive surface and a substrate proximate said abrasive surface; and wherein said conditioning disk further comprises a carrier affixed to said substrate.
- 2-5. (canceled)
6. (currently amended) The system of claim [[5]] 1 wherein said carrier is an electrical insulator.
7. (original) The system of claim 6 wherein said carrier is formed from polycarbonate.
8. (currently amended) The system of claim [[4]] 1 wherein said substrate is conductive.
9. (original) The system of claim 8 wherein said substrate comprises nickel.

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10. (original) The system of claim 9 wherein said abrasive surface comprises a plurality of abrasive particles affixed to said substrate with a metal matrix.
11. (original) The system of claim 10 wherein said abrasive particles comprise diamonds.
12. (original) The system of claim 10 wherein said metal matrix comprises nickel.
13. (currently amended) A method of conditioning an electrochemical-mechanical polishing pad comprising:
electrically insulating an abrasive surface of a conditioning tool; wherein said conditioning tool comprises an electrically insulated conditioning disk comprising a substrate proximate said abrasive surface and a carrier affixed to said substrate;
contacting said abrasive surface with said polishing pad; and
moving said abrasive surface relative to said polishing pad.
14. (canceled)
15. (original) The method of claim [[14]] 13 wherein said carrier is an electrical insulator.
16. (original) The method of claim 15 wherein said carrier is formed from polycarbonate.
- 17-20. (canceled)